Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10574350	SCHWOERER, LUDWIG
Examiner	Art Unit
BENJAMIN ELLIOTT	2474

SEARCHED

Class	Subclass	Date	Examiner
370	206, 208, 491	1/27/2009	BHE
UPDATED	UPDATED	UPDATED	UPDATED
370	206, 208, 491, 503, 512, 520	10/26/2009	BHE
375	all	10/26/2009	BHE
UPDATED	UPDATED	UPDATED	UPDATED
370	206, 208, 491, 503, 512, 520	7/24/2010	BHE
375	all	7/24/2010	BHE
455	all		

SEARCH NOTES

Search Notes	Date	Examiner
Reviewed PCT report and IDS	1/27/2009	BHE
Inventor search	1/27/2009	BHE
Classification search	1/27/2009	BHE
PLUS search	1/27/2009	BHE
Internet and Google search	1/27/2009	BHE
IEEE search conducted for NPL relating to Claims 9-14. Search terms incude: [accumulat\$ and OFDM and (time slicing) or (time slot)], [multicarrier and OFDM and pilot], and [fast scattered and OFDM]	1/27/2009	BHE
Cosulted with Hassan Kizou with regards to the allowability of Claims 9-14.	1/27/2009	BHE
UPDATED	UPDATED	UPDATED
Re-visisted IDS and PCT information	10/26/2009	BHE
Inventor and assignee search through PALM and eDAN	10/26/2009	BHE
Reviewed Applicants' previously rejected applications for relevant prior art references	10/26/2009	BHE
Consulted with Jeffery Rutkowski, primary examiner, AU 2400, regarding arguements and Hayashi reference reading on Claim 1.	10/26/2009	BHE
Updated classification search	10/26/2009	BHE
Updated EAST search	10/26/2009	BHE
UPDATED	UPDATED	UPDATED
Reviewed Applicant's arguments, previous grounds of rejection, references used, and application disclosure	7/24/2010	BHE
Reviewed case with Aung Moe, SPE 2474	7/24/2010	BHE

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SEARCH NOTES		
Search Notes	Date	Examiner
Updated classification search (see attached class/sub-class) with limted text search in EAST: "pilot and carrier and symbol and power with (add\$6 sum\$5) and ofdm and dvb"	7/24/2010	BHE
Inventor search through IEEE Explore	7/24/2010	BHE
EAST search	7/24/2010	BHE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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